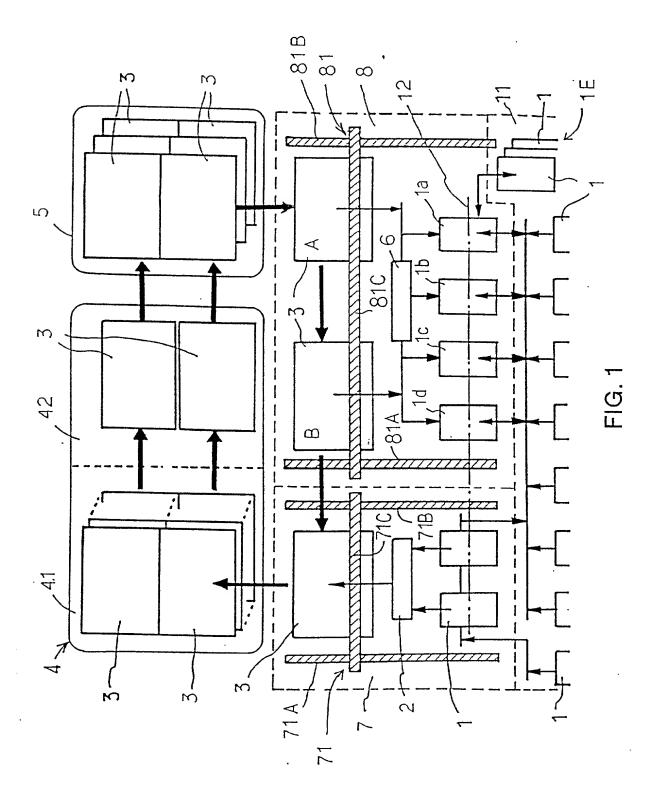
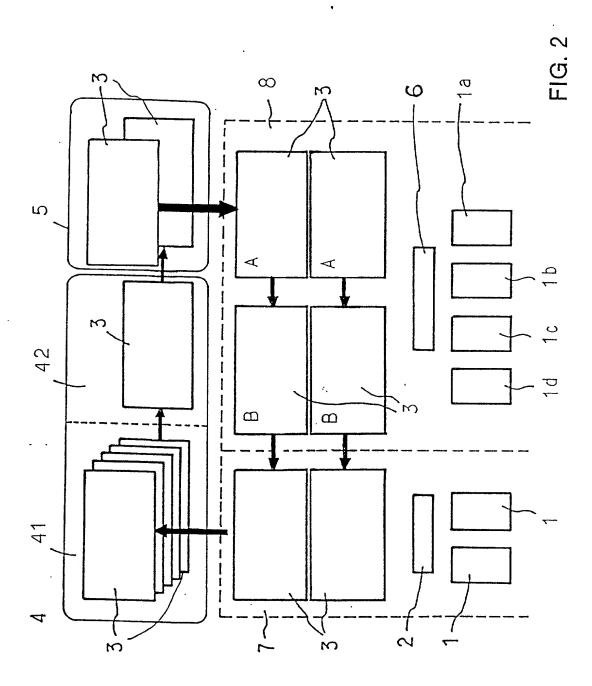
Title: SEMICONDUCTOR DEVICE TESTING APPARATUS AND A TEST TRAY FOR USE IN THE TESTING APPARATUS First Inventor: Akihiko ITO, et al.
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3 111111111111111111 11111111111111

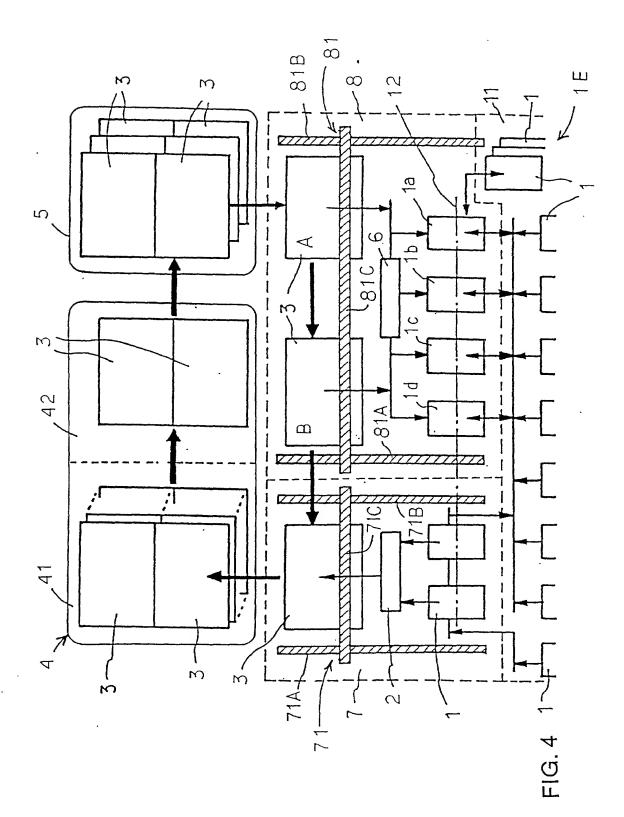
FIG. 3(a)

```
111111111111111111
            3 1
  111111111111111
111111111111111111
   111111111111111
```

FIG. 3(b)

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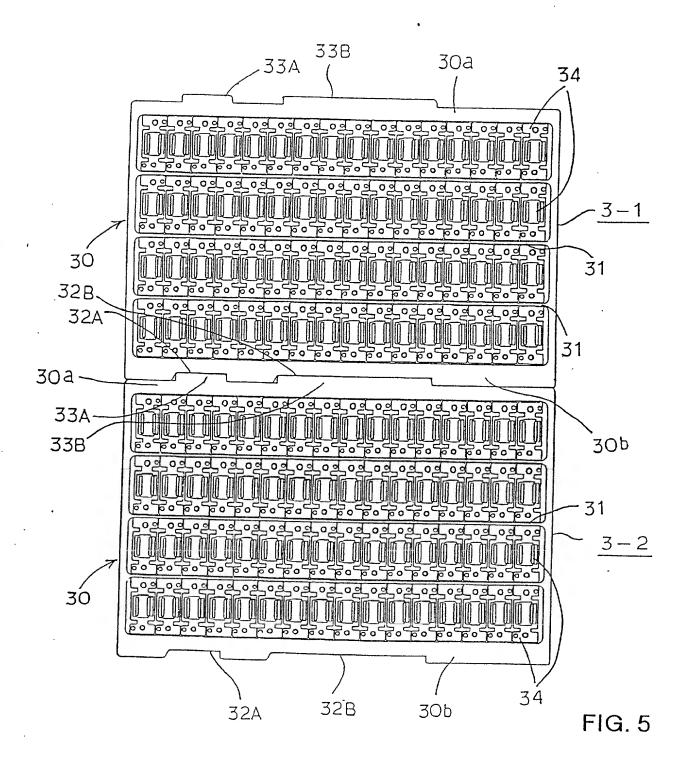
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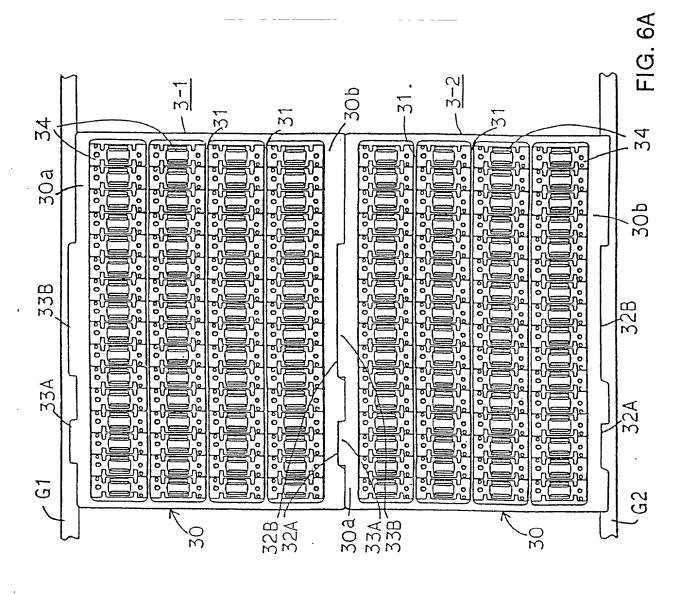
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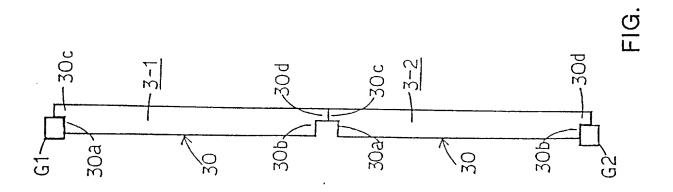
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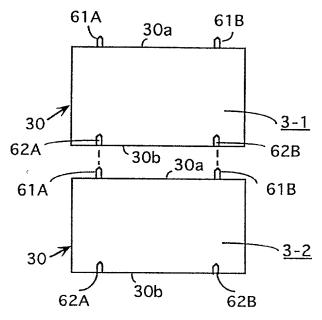


FIG. 7A

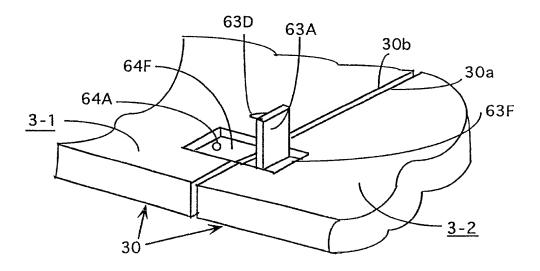
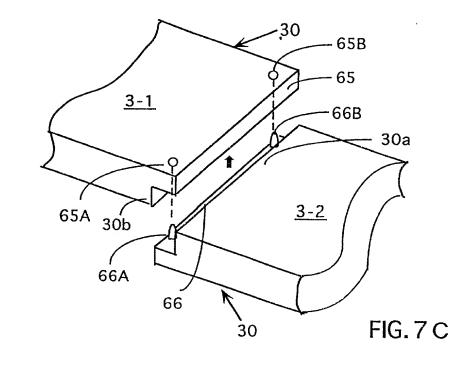
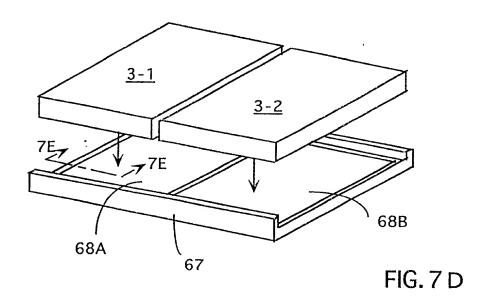


FIG. 7B

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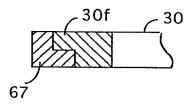
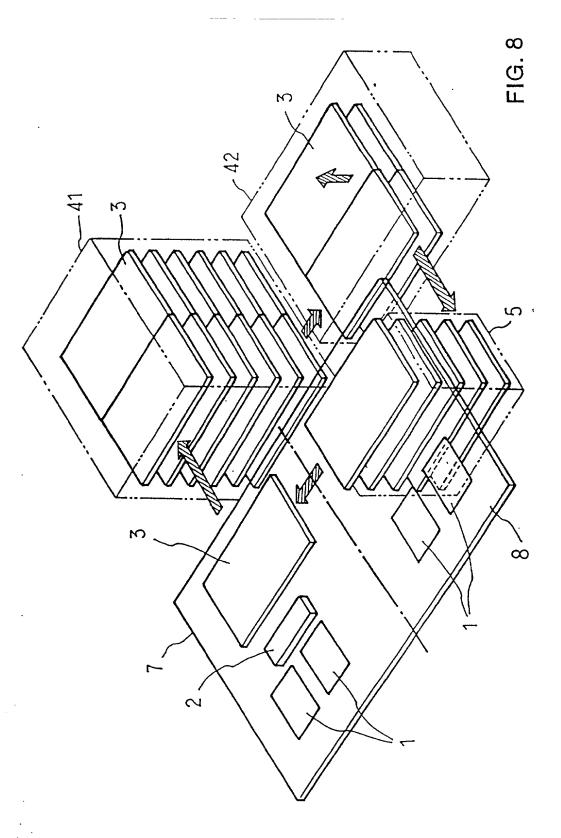


FIG. 7 E

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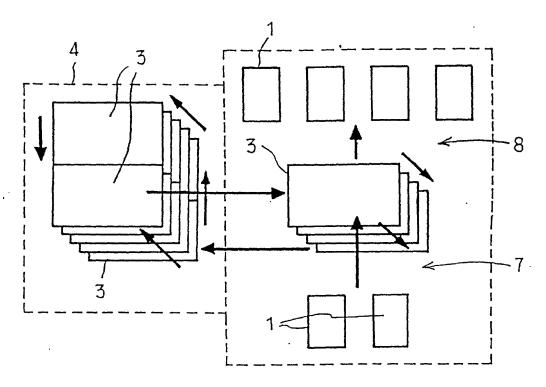
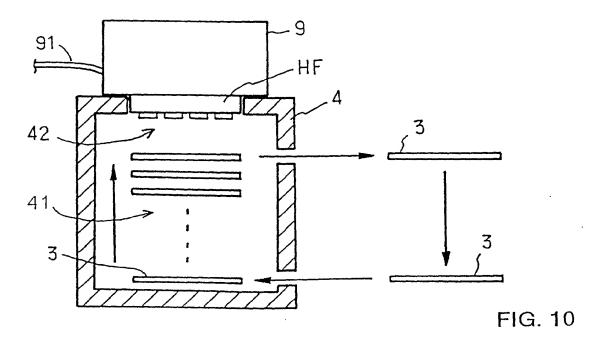
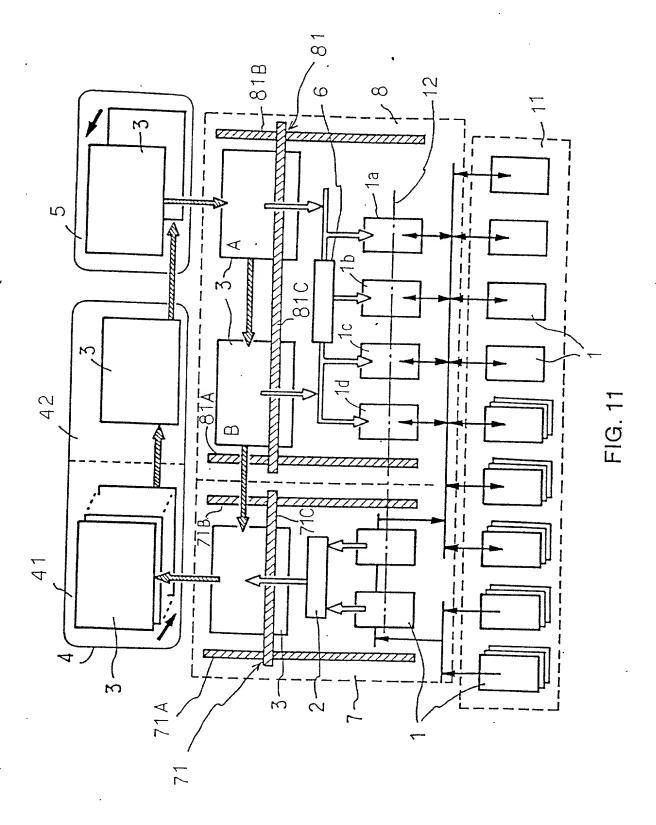


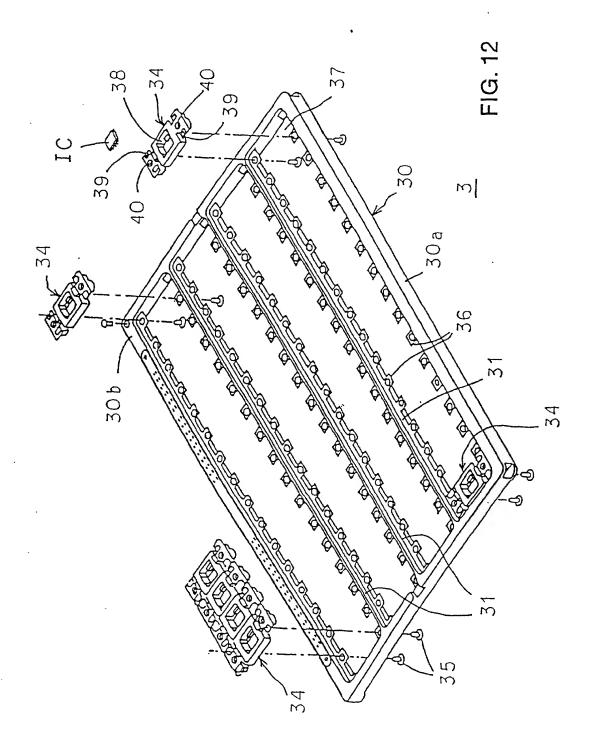
FIG. 9



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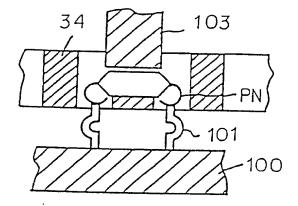
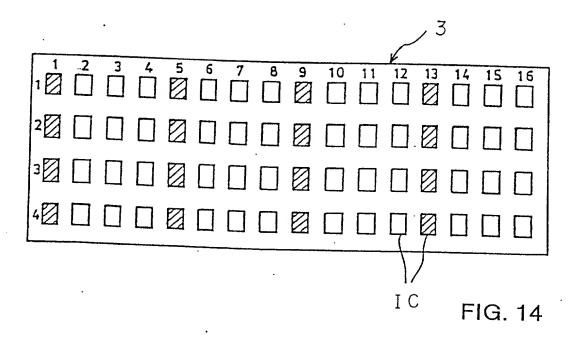


FIG. 13



Title: SEMICONDUCTOR DEVICE TESTING APPARATUS AND A TEST TRAY FOR USE IN THE TESTING APPARATUS First Inventor: Akihiko ITO, et al.
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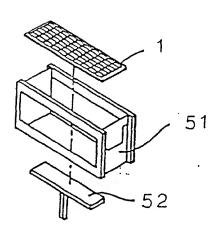


FIG. 15